

Special Topics on Basic EECS I

Design Technology Co-Optimization

Lecture 17

Sung-Min Hong (smhong@gist.ac.kr)

Semiconductor Device Simulation Laboratory

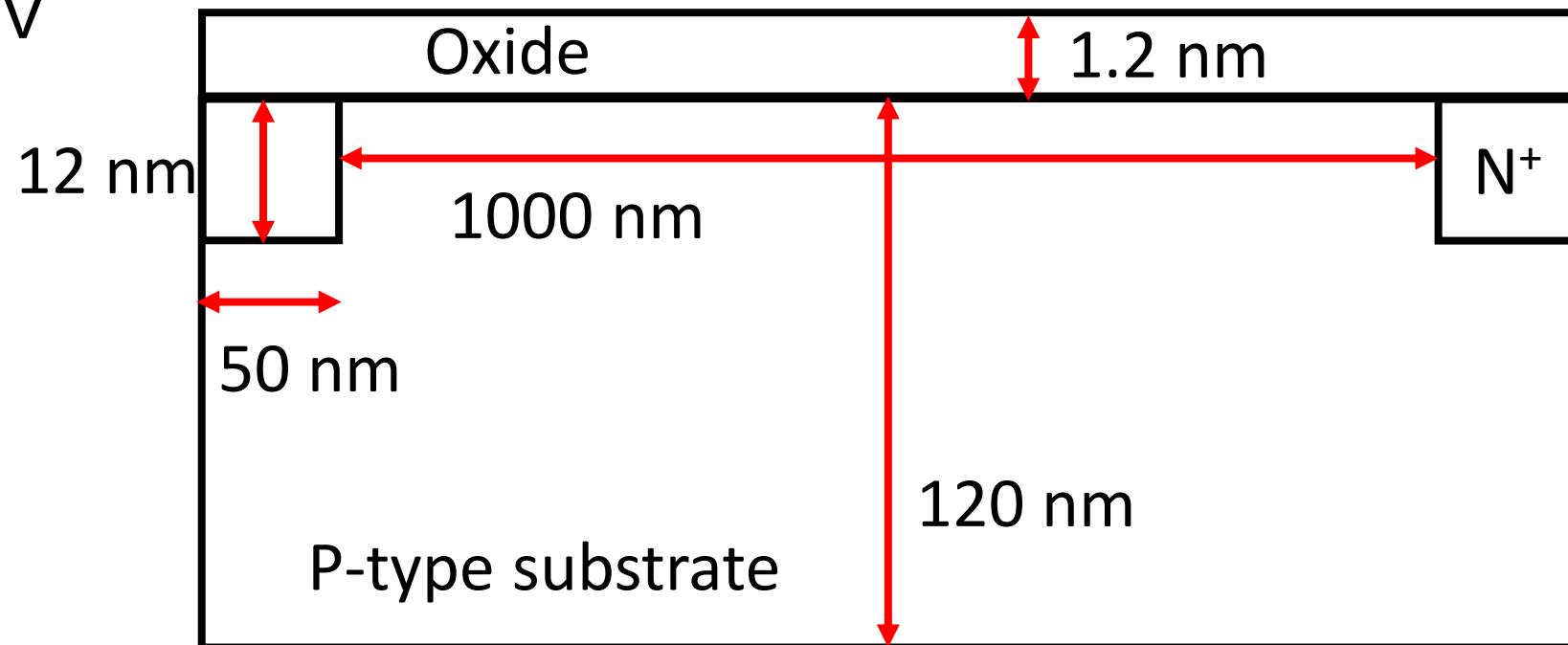
Department of Electrical Engineering and Computer Science

Gwangju Institute of Science and Technology (GIST)

L17

Simulation of a long-channel MOSFET

- Effective oxide thickness of 1.2 nm
 - Gate workfunction of 4.3 eV
 - Substrate doping of $1.5 \times 10^{18} \text{ cm}^{-3}$
 - V_{DD} of 1.2 V



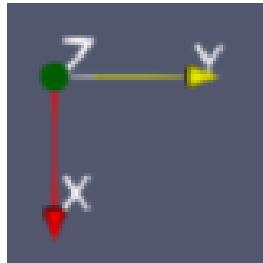
Structure generation

- Spacing along the vertical direction: 1.2 nm
 - Spacing along the lateral direction: 5 nm
 - How many points? $102 \times 221 = 22542$
 - Too many points for such a simple structure...
- Source/drain doping profile
 - Gaussian profile is usually used.
 - In this example, abrupt junctions are assumed.

Mapmaker

- Input file

- x : Depth
- y : Channel
- z : Width



```
thing (type="mapmaker",name="structure") {
    mapmaker (type="3d",cgns="long.cgns") {
        cuboid (x0=-1.2nm,y0=-550nm,x1=120nm,y1=550nm,z0=0.0,z1=1.0um,nx=102,ny=221,nz=2)
        region (name="semiconductor",material="silicon",ix0=1,ix1=101,iy0=0,iy1=220,iz0=0,iz1=1)
        region (name="insulator", material="oxide", ix0=0,ix1=1, iy0=0,iy1=220,iz0=0,iz1=1)
        doping (region="semiconductor",ix0=1,ix1=101,iy0=0, iy1=220,iz0=0,iz1=1,density=-1.5e18/cm3)
        doping (region="semiconductor",ix0=1,ix1=11, iy0=0, iy1=10, iz0=0,iz1=1,density=2e20/cm3)
        doping (region="semiconductor",ix0=1,ix1=11, iy0=210,iy1=220,iz0=0,iz1=1,density=2e20/cm3)
        contact (name="source",ix0=1, ix1=6, iy0=0, iy1=0, iz0=0,iz1=1)
        contact (name="gate", ix0=0, ix1=0, iy0=10, iy1=210,iz0=0,iz1=1)
        contact (name="drain", ix0=1, ix1=6, iy0=220,iy1=220,iz0=0,iz1=1)
        contact (name="body", ix0=101,ix1=101,iy0=0, iy1=220,iz0=0,iz1=1)
    }
}
```

Long-channel device structure

- It is not very realistic.
 - Abrupt source/drain doping
 - Constant substrate doping
 - Spacer
 - Source/drain contact



Loading the structure

- In a MOSFET, we have a gate contact.
 - The workfunction must be specified.
 - Do not forget to specify the bandgap narrowing model.

```
thing (type="device",name="mosfet") {  
    device (type="3d",areafactor=1.0) {  
        load (cgns="long.cgns",dbpath="/Here goes your dbpath.")  
        electrode (name="gate",workfunction=4.3)  
    }  
}  
  
property (thing="mosfet",model="effectiveintrinsicscdensity",nobandgapnarrowing)
```

Building a circuit

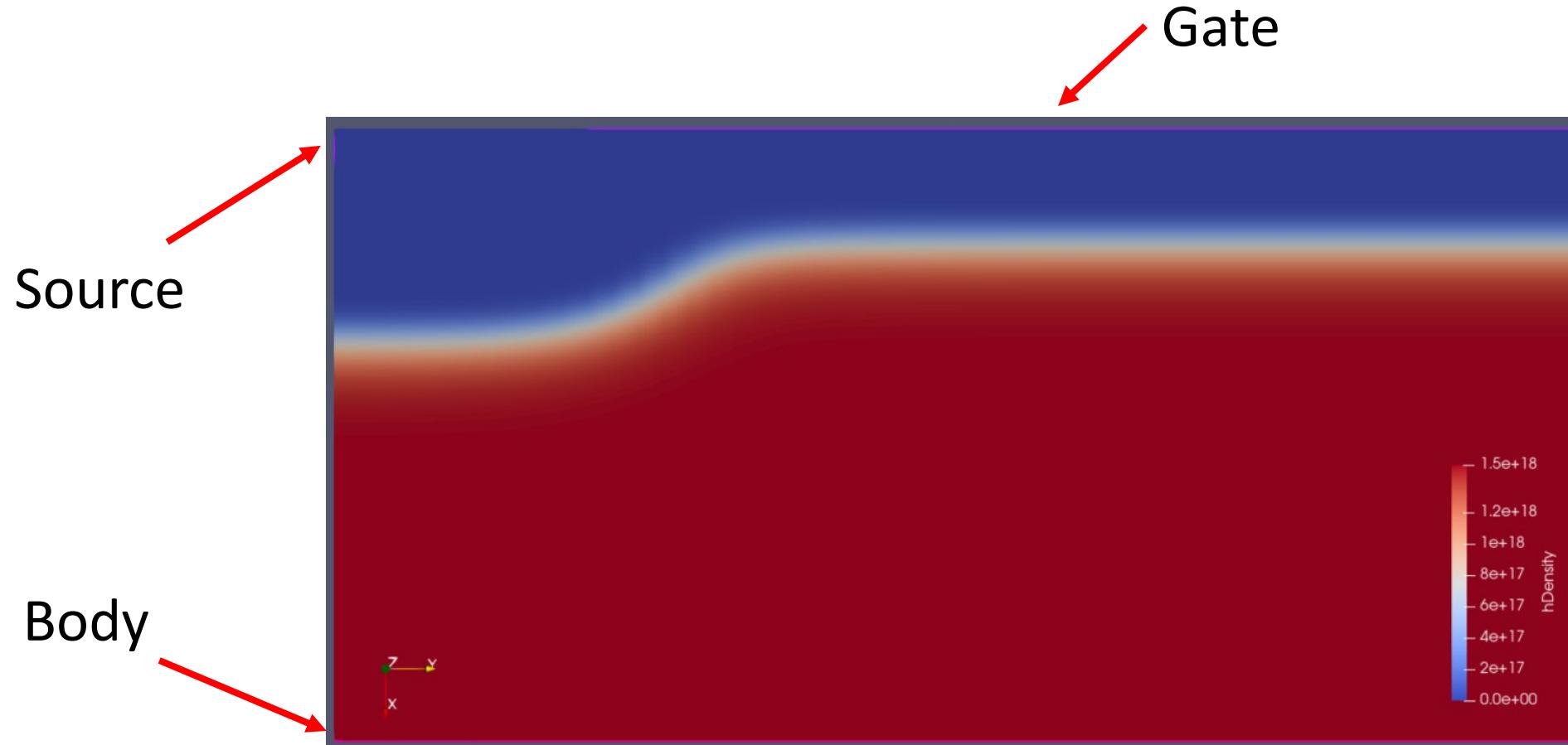
- We need (at least) two voltage sources.
 - Prepare them (v_g and v_d in this example) and build a circuit.

```
thing (type="lumped",name="vg") {  
    lumped (type="v",value=0.0)  
}  
  
thing (type="lumped",name="vd") {  
    lumped (type="v",value=0.0)  
}  
  
thing (type="circuit",name="circuit") {  
    circuit {  
        node (thing="gnd",name="GND")  
        node (thing="mosfet", contact="source",name="GND")  
        node (thing="mosfet", contact="gate" ,name="IN")  
        node (thing="mosfet", contact="drain" ,name="OUT")  
        node (thing="mosfet", contact="body" ,name="GND")  
        node (thing="vg", contact="0" , name="GND")  
        node (thing="vg", contact="1" , name="IN")  
        node (thing="vd", contact="0" , name="GND")  
        node (thing="vd", contact="1" , name="OUT")  
    }  
}
```

Equilibrium

```
law (name="eqlaw") {  
    equation (type="poisson",thing="mosfet")  
}  
  
solve (law="eqlaw",initialstep=1.0,plot,plotprefix="long_eq",cgns)
```

- Depletion of holes



Setting a law and a book

- Drift-diffusion simulation and IV curves
 - There are two voltage sources. Therefore, we need to specify the “virlc” equation twice.

```
law (name="dclaw",iteration=12) {  
    equation (type="poisson" ,thing="mosfet")  
    equation (type="econtinuity",thing="mosfet")  
    equation (type="hcontinuity",thing="mosfet")  
    equation (type="contact" ,thing="mosfet")  
    equation (type="virlc" ,thing="vg")  
    equation (type="virlc" ,thing="vd")  
    equation (type="kirchhoff" ,thing="circuit")  
}  
  
book (name="input_iv", csv="input_iv.csv") {  
    event (thing="mosfet", contact="gate")  
    event (thing="mosfet", contact="drain")  
}
```

Bias ramping

- Usually, we consider two drain voltages.
 - A voltage close to zero, $V_D \approx 0$ V & a voltage equal to V_{DD}
 - In the following example, we take 0.05 V.

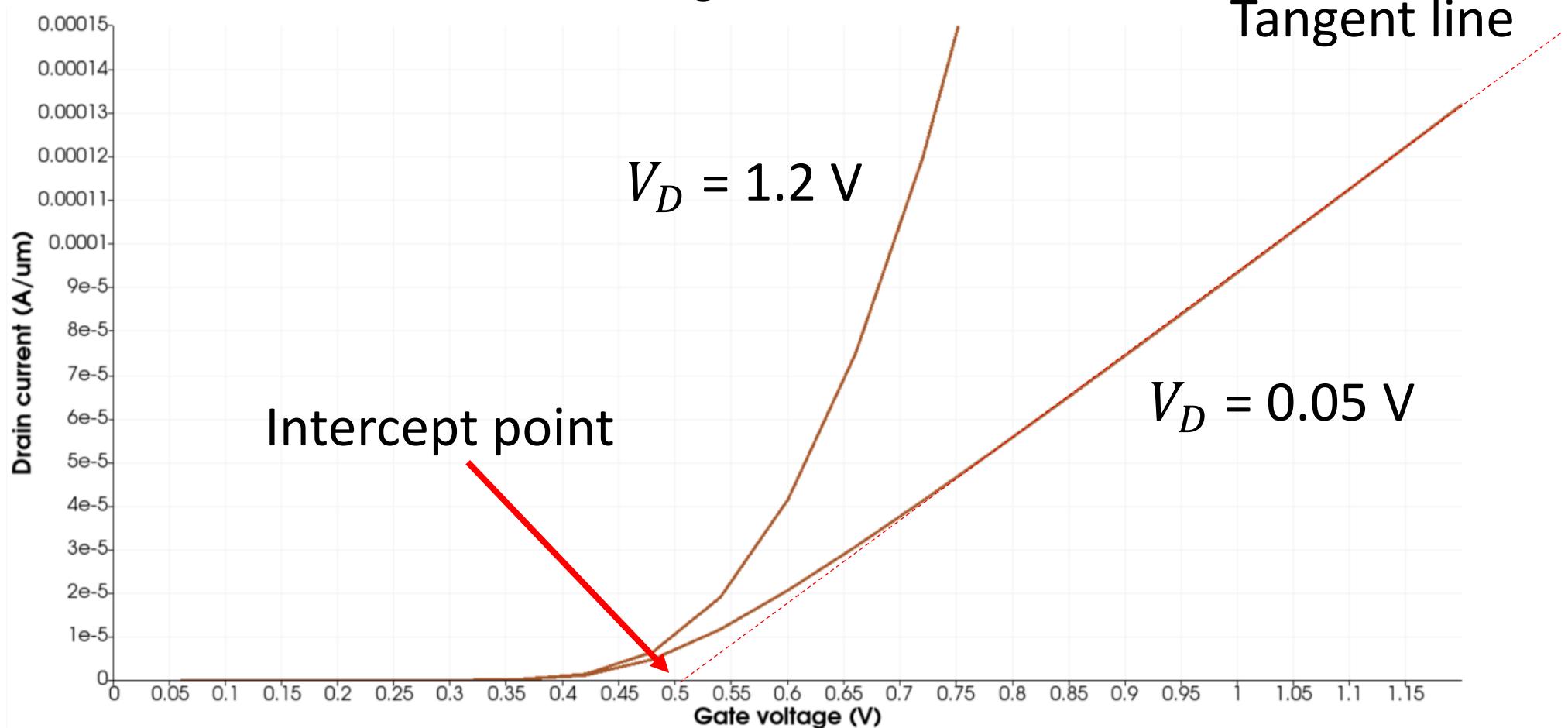
```
solve (law="dclaw",initialstep=1.0) {
    goal (thing="vd", quantity="voltage", value=0.05)
}
```

- After running this solve statement, we have a solution at $V_G = 0$ V and $V_D = 0.05$ V.
- Then,

```
solve (law="dclaw",initialstep=0.01,maxstep=0.01,minstep=0.01,plot,plotprefix="long_dc",cgns,book="input_iv") {
    goal (thing="vg", quantity="voltage", value=1.2)
}
```

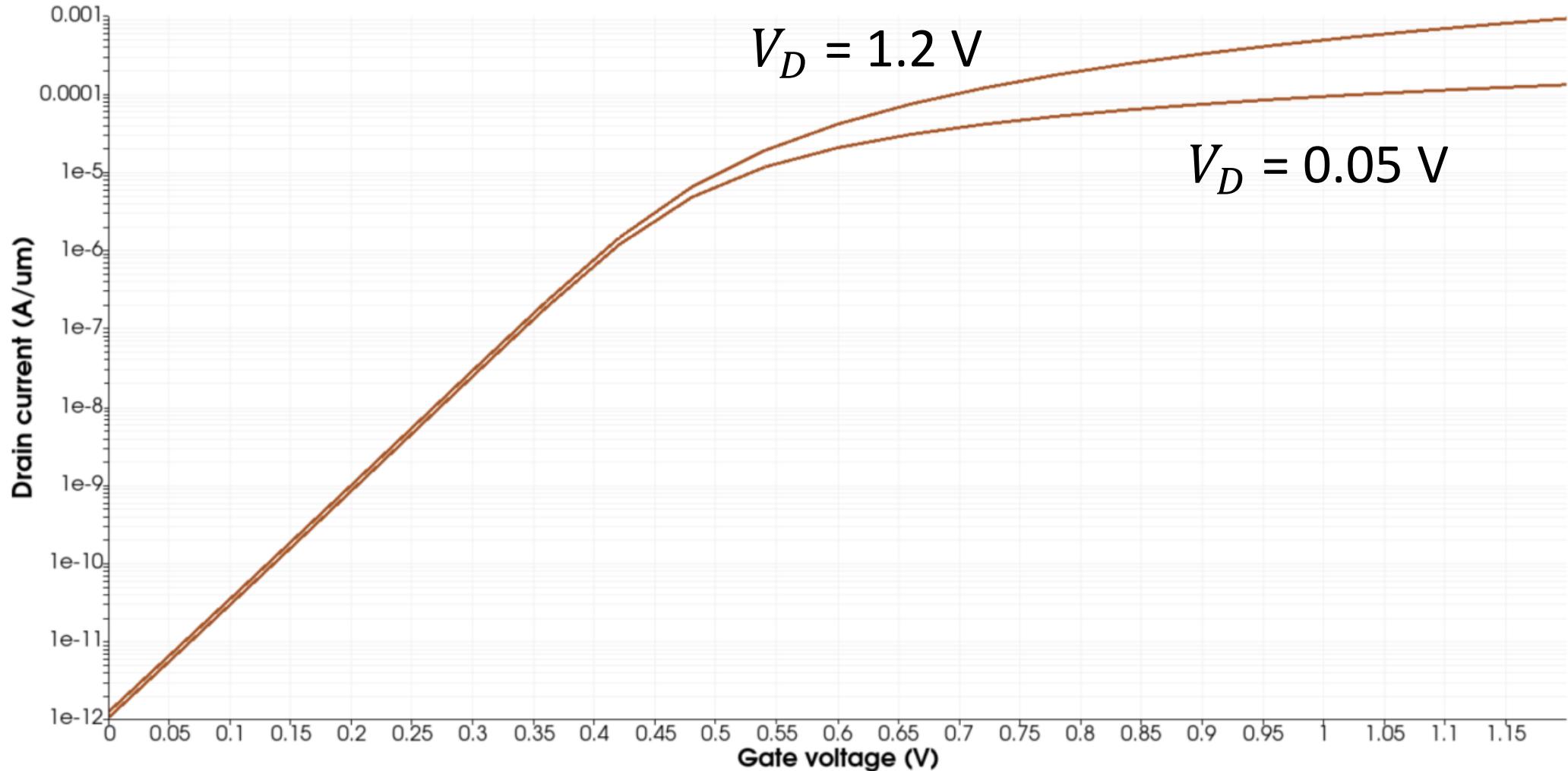
Ramping the gate voltage up

- Results WITHOUT any physical model, from 0 V to 1.2 V
 - Estimate the threshold voltage.



Semi-logarithmic graph

- Estimate the subthreshold slope, the DIBL, I_{ON} , and I_{OFF} .



Thank you!